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Email & Skype: info@chipsmall.com Web: www.chipsmall.com

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FDS4897C

Dual N & P-Channel PowerTrench® MOSFET

General Description

These dual N- and P-Channel enhancement mode power field effect transistors are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

Application

- Inverter
- Power Supplies



Features

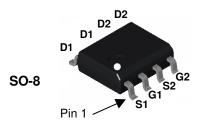
Q1: N-Channel

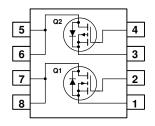
6.2A, 40V
$$R_{DS(on)} = 29m\Omega$$
 @ $V_{GS} = 10V$ $R_{DS(on)} = 36m\Omega$ @ $V_{GS} = 4.5V$

Q2: P-Channel

$$-4.4A$$
, $-40V$ R_{DS(on)} = $46mΩ$ @ V_{GS} = $-10V$
R_{DS(on)} = $63mΩ$ @ V_{GS} = $-4.5V$

- High power handling capability in a widely used surface mount package
- RoHS compliant





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DSS}	Drain-Source Voltage		40	40	V
V _{GSS}	Gate-Source Voltage		±20	±20	V
I _D	Drain Current - Continuous	(Note 1a)	6.2	-4.4	Α
	- Pulsed		20	-20	
P _D	Power Dissipation for Dual Operation			W	
	Power Dissipation for Single Operation	(Note 1a)	1	1.6	
		(Note 1b)		1	
		(Note 1c)	().9	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		–55 t	o +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
R _{eJC}	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

Package Marking and Ordering Information

_		3	<u> </u>		
Device Marking		Device	Reel Size	Tape width	Quantity
FDS4897C		FDS4897C	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Drain-So	ource Avalanche Rating	S (Note 3)					
E _{AS}	Drain-Source Avalanche Energy (Single Pulse)	$V_{DD} = 40 \text{ V}, I_D = 7.3 \text{ A}, L = 1 \text{ mH}$	Q1			27	mJ
	Energy (Single Pulse)	$V_{DD} = -40 \text{ V}, I_D = -8.7 \text{ A}, L = 1 \text{ mH}$	Q2			38	mJ
I _{AS}	Drain-Source Avalanche Current		Q1 Q2		7.3 –8.7		Α
Off Chai	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_D = 250 \mu\text{A} \\ V_{GS} = 0 \text{ V}, \qquad I_D = -250 \mu\text{A}$	Q1 Q2	40 -40			V
∆BV _{DSS}	Breakdown Voltage	$I_D = 250 \mu A$, Referenced to 25°C	Q1		34		mV/°C
ΔT_J	Temperature Coefficient	$I_D = -250 \mu A$, Referenced to $25^{\circ}C$	Q2		-40		
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 32 \text{ V}, \qquad V_{GS} = 0 \text{ V} $ $V_{DS} = -32 \text{ V}, \qquad V_{GS} = 0 \text{ V}$	Q1 Q2			1 -1	μΑ
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$	All			±100	nA
On Char	acteristics (Note 2)	•					
$V_{GS(th)}$	Gate Threshold Voltage	$\begin{array}{ll} V_{DS} = V_{GS}, & I_{D} = 250 \; \mu A \\ V_{DS} = V_{GS}, & I_{D} = -250 \; \mu A \end{array}$	Q1 Q2	1 –1	1.9 -1.7	3 -3	V
$\Delta V_{GS(th)}$	Gate Threshold Voltage	$I_D = 250 \mu A$, Referenced to 25°C	Q1		- 5		mV/°C
ΔT_J	Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C	Q2		4		
R _{DS(on)}	Static Drain-Source On-Resistance	$\begin{array}{lll} V_{GS} = 10 \ V, & I_D = 6.2 \ A \\ V_{GS} = 4.5 \ V, & I_D = 4.8 \ A \\ V_{GS} = 10 \ V, & I_D = 6.2 \ A, \ T_J = 125^{\circ}C \end{array}$	Q1		21 26 29	29 36 43	mΩ
		$\begin{tabular}{lllllllllllllllllllllllllllllllllll$	Q2		37 50 55	46 63 73	
g FS	Forward Transconductance	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 6.2 \text{ A} $ $V_{DS} = -10 \text{ V}, \qquad I_{D} = -4.4 \text{ A}$	Q1 Q2		21 12		S
Dvnami	c Characteristics						
Ciss	Input Capacitance	Q1 $V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	Q1 Q2		760 1050		pF
C _{oss}	Output Capacitance	Q2	Q1 Q2	-	100 140		pF
C _{rss}	Reverse Transfer Capacitance	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	Q1 Q2		60 70		pF
R _G	Gate Resistance	f = 1.0 MHz	Q1		1.2		Ω

Electrical Characteristics (continued) T _A = 25°C unless otherwise noted							
Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Switchir	ng Characteristics (Note	2)					
$t_{\text{d(on)}}$	Turn-On Delay Time	Q1 $V_{DD} = 20 \text{ V}, I_{D} = 1 \text{ A},$	Q1 Q2		9 12	18 22	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V$, $R_{GEN} = 6 \Omega$	Q1 Q2		5 15	10 27	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time	$Q2$ $V_{DD} = -20 \text{ V}, I_D = -1 \text{ A},$	Q1 Q2		23 45	37 72	ns
t _f	Turn-Off Fall Time	$V_{GS} = -10V$, $R_{GEN} = 6 \Omega$	Q1 Q2		3 18	6 32	ns
Qg	Total Gate Charge	Q1 $V_{DS} = 20 \text{ V}, I_D = 6.2 \text{ A}, V_{GS} = 10 \text{ V}$	Q1 Q2		14 20	20 28	nC
Q_{gs}	Gate-Source Charge	Q2	Q1 Q2		2.4 3		nC
Q_{gd}	Gate-Drain Charge	$V_{DS} = -20 \text{ V}, I_{D} = -4.4 \text{ A}, V_{GS} = -10 \text{ V}$	Q1 Q2		2.8 4		nC
Drain-S	Source Diode Character	ristics					
V _{SD}	Drain-Source Diode Forward Voltage	$ \begin{array}{c} V_{GS} = 0 \ V, \ I_S = 1.3 \ A \\ V_{GS} = 0 \ V, \ I_S = -1.3 \ A \end{array} \qquad \begin{array}{c} \text{(Note 2)} \\ \text{(Note 2)} \end{array} $	Q1 Q2		0.7 -0.7	1.2 -1.2	V
t _{rr}	Diode Reverse Recovery Time	Q1 $I_F = 6.2 \text{ A}, d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$	Q1 Q2		17 24		ns
Q _{rr}	Diode Reverse Recovery Charge	Q2 $I_F = -4.4 \text{ A, } d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$	Q1 Q2		7 12		nC

Notes:

 R_{aJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{aJC} is guaranteed by design while R_{aCA} is determined by the user's board design.



a) 78°C/W when mounted on a 0.5 in² pad of 2 oz copper



b) 125°C/W when mounted on a .02 in² pad of 2 oz copper



c) 135°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

- 2. Pulse Test: Pulse Width < $300\mu s$, Duty Cycle < 2.0%
- 3. BV(avalanche) Single-Pulse rating is guaranteed by design if device is operated within the UIS SOA boundary of the device.

Typical Characteristics: Q1 (N-Channel)

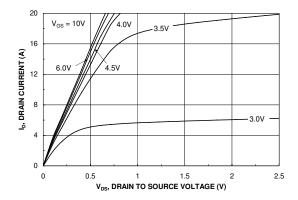


Figure 1. On-Region Characteristics.

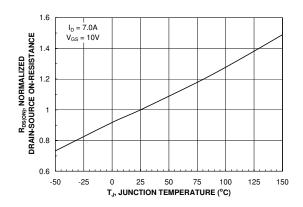


Figure 3. On-Resistance Variation with Temperature.

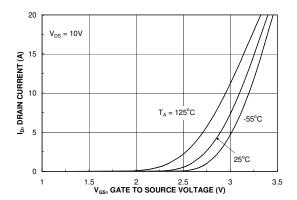


Figure 5. Transfer Characteristics.

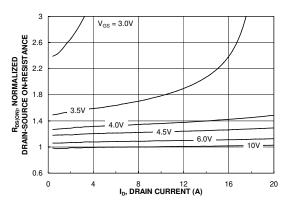


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

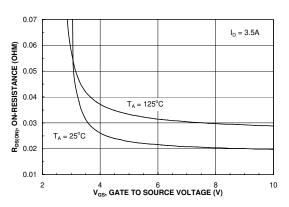


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

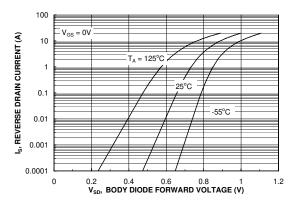


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: Q1 (N-Channel)

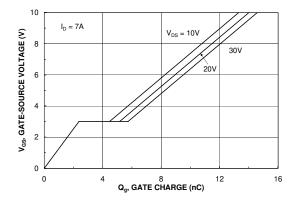


Figure 7. Gate Charge Characteristics.

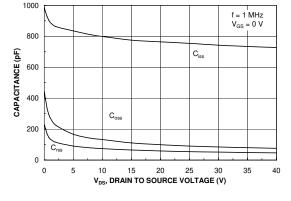


Figure 8. Capacitance Characteristics.

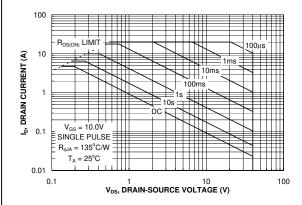


Figure 9. Maximum Safe Operating Area.

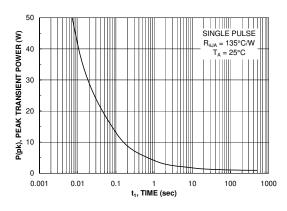


Figure 10. Single Pulse Maximum Power Dissipation.

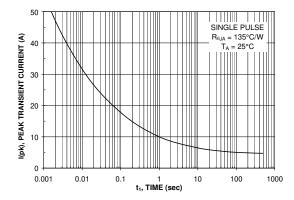


Figure 11. Single Pulse Maximum Peak Current.

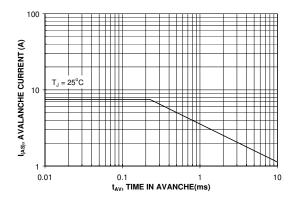


Figure 12. Unclamped Inductive Switching Capability.

Typical Characteristics: Q2 (P-Channel)

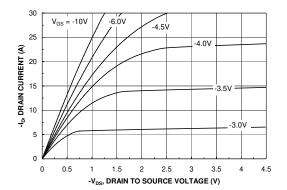


Figure 13. On-Region Characteristics.

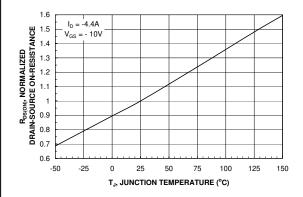


Figure 15. On-Resistance Variation with Temperature.

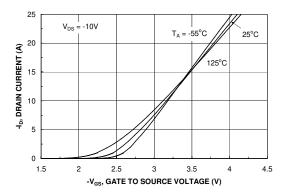


Figure 17. Transfer Characteristics.

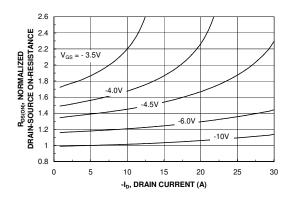


Figure 14. On-Resistance Variation with Drain Current and Gate Voltage.

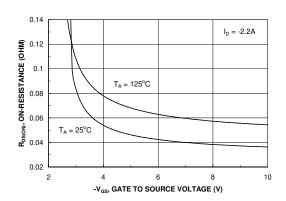


Figure 16. On-Resistance Variation with Gate-to-Source Voltage.

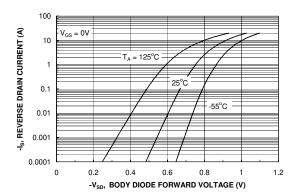


Figure 18. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: Q2 (P-Channel)

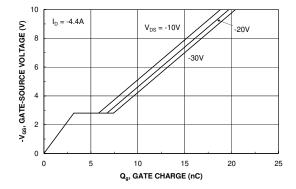
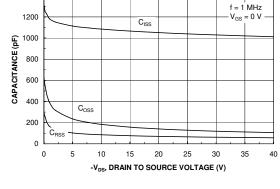


Figure 19. Gate Charge Characteristics.



1400

Figure 20. Capacitance Characteristics.

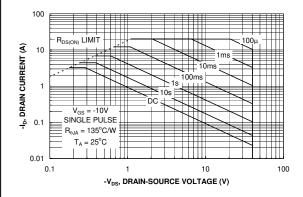


Figure 21. Maximum Safe Operating Area.

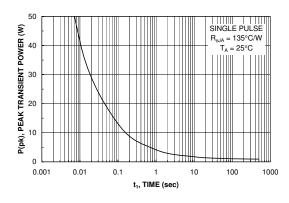


Figure 22. Single Pulse Maximum Power Dissipation.

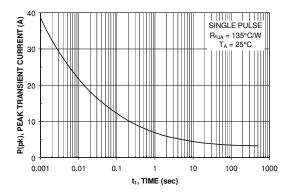


Figure 23. Single Pulse Maximum Peak Current

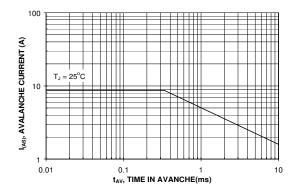


Figure 24. Unclamped Inductive Switching Capability

Typical Characteristics: N and P-Channel

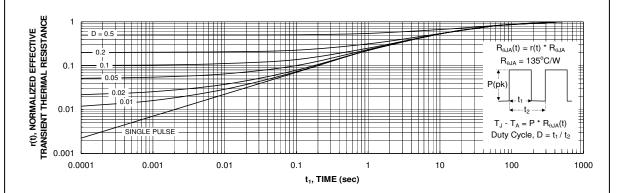


Figure 25. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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